

Notice of References Cited	Application/Control No. 10/553,246		Applicant(s)/Patent Under Reexamination MUTO, SHIN	
	Examiner Imad Hussain		Art Unit 2109	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,915,119 A	06-1999	Cone, Kevin A.	713/310
*	B	US-6,459,496 B1	10-2002	Okazawa, Takashi	358/1.14
*	C	US-2002/0188759 A1	12-2002	Roy et al.	709/245
*	D	US-2003/0018829 A1	01-2003	Carney et al.	709/321
*	E	US-2004/0061909 A1	04-2004	Ferlitsch et al.	358/474
*	F	US-2004/0184427 A1	09-2004	Lynch et al.	370/342
*	G	US-7,107,442 B2	09-2006	Cheshire, Stuart D.	713/1
*	H	US-5,282,270 A	01-1994	Oppenheimer et al.	709/223
*	I	US-6,020,973	02-2000	Levine et al.	358/1.15
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.